Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/022,594	KAMIYA ET AL.	
Examiner	Art Unit	
Shick C. Hom	2616	

SEARCHED					
Class	Subclass	Date	Examiner		
370	218, 243	5/14/2007	SH		
		*** · · · · · · · · · · · · · · · · · ·			
		-			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	218, 242,	5/15/2007	sн	
370	243, 244,	5/15/2007	SH	
370	245, 401,	5/15/2007	SH	
370/395.3, 395.5, 395.51, 395.53, 395.6, 402, 403, 470, 474,		5/15/2007	ѕн	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East search	5/14/2007	SH ·		
consulted with Seema Rao on 370 search	5/14/2007	SH		
Inventor search	5/15/2007	SH		
·				